

Description

The VSM1013E uses advanced trench technology to provide excellent $R_{DS(ON)}$, low gate charge and operation with gate voltages as low as -1.8V. This device is suitable for use as a Battery protection or in other Switching application.

General Features

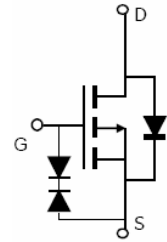
- $V_{DS} = -20V, I_D = -0.66A$
 $R_{DS(ON)} < 520m\Omega @ V_{GS} = -4.5V$
 $R_{DS(ON)} < 700m\Omega @ V_{GS} = -2.5V$
 $R_{DS(ON)} < 1000m\Omega @ V_{GS} = -1.8V$
ESD Rating : HBM 2000V
- High power and current handling capability
- Lead free product is acquired
- Gate-Source ESD protection

Application

- Battery operated systems
- Load/ power switching cell phones pagers
- Power supply converter circuits



SOT-23-3



Schematic Diagram

Package Marking and Ordering Information

Device Marking	Device	Device Package	Reel Size	Tape width	Quantity
VSM1013E-S2	VSM1013E	SOT-23-3	Ø180mm	8 mm	3000units

Absolute Maximum Ratings ($T_A = 25^\circ C$ unless otherwise noted)

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	V_{DS}	-20	V
Gate-Source Voltage	V_{GS}	± 12	V
Drain Current-Continuous	I_D	-0.66	A
Drain Current-Pulsed (Note 1)	I_{DM}	-3	A
Maximum Power Dissipation	P_D	0.3	W
Operating Junction and Storage Temperature Range	T_J, T_{STG}	-55 To 150	$^\circ C$

Thermal Characteristic

Thermal Resistance, Junction-to-Ambient (Note 2)	$R_{\theta JA}$	417	$^\circ C/W$
--	-----------------	-----	--------------

Electrical Characteristics ($T_A = 25^\circ C$ unless otherwise noted)

Parameter	Symbol	Condition	Min	Typ	Max	Unit
Off Characteristics						
Drain-Source Breakdown Voltage	BV_{DSS}	$V_{GS} = 0V, I_D = -250\mu A$	-20	-	-	V

Parameter	Symbol	Condition	Min	Typ	Max	Unit
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} =-20V, V _{GS} =0V	-	-	1	μA
Gate-Body Leakage Current	I _{GSS}	V _{GS} =±10V, V _{DS} =0V	-	-	±10	μA
On Characteristics (Note 3)						
Gate Threshold Voltage	V _{GS(th)}	V _{DS} =V _{GS} , I _D =-250μA	-0.5	-0.6	-0.9	V
Drain-Source On-State Resistance	R _{DS(ON)}	V _{GS} =-4.5V, I _D =-0.6A	-	362	520	mΩ
		V _{GS} =-2.5V, I _D =-0.5A	-	471	700	mΩ
		V _{GS} =-1.8V, I _D =-0.4A	-	837	1000	mΩ
Forward Transconductance	g _{FS}	V _{DS} =-5V, I _D =-0.6A	-	1	-	S
Dynamic Characteristics (Note4)						
Input Capacitance	C _{Iss}	V _{DS} = -10 V , V _{GS} = 0 V, F= 1.0 MHz,	-	114	-	pF
Output Capacitance	C _{Oss}		-	17	-	pF
Reverse Transfer Capacitance	C _{rss}		-	14	-	pF
Switching Characteristics (Note 4)						
Turn-on Delay Time	t _{d(on)}	V _{DD} = -10 V, R _L = 47Ω V _G = -4.5 V, R _G = 10Ω	-	6.5	-	nS
Turn-on Rise Time	t _r		-	6.5	-	nS
Turn-Off Delay Time	t _{d(off)}		-	18.2	-	nS
Turn-Off Fall Time	t _f		-	5.5	-	nS
Total Gate Charge	Q _g	V _{DS} =- 10 V, V _{GS} = -4.5 V, I _D = -0.6A	-	1.44	-	nC
Gate-Source Charge	Q _{gs}		-	0.14	-	nC
Gate-Drain Charge	Q _{gd}		-	0.35	-	nC
Drain-Source Diode Characteristics						
Diode Forward Voltage (Note 3)	V _{SD}	V _{GS} =0V, I _S =-0.6A	-	-	-1.2	V
Diode Forward Current (Note 2)	I _S		-	-	-0.6	A

Notes:

1. Repetitive Rating: Pulse width limited by maximum junction temperature.
2. Surface Mounted on 1in 2 FR-4 board with 2oz. Copper, in a still air environment with $T_A = 25^\circ C$. The value in any given application depends on the user's specific board design. The current rating is based on the $t \leq 10s$ thermal resistance rating.
3. Pulse Test: Pulse Width $\leq 300\mu s$, Duty Cycle $\leq 2\%$.
4. Guaranteed by design, not subject to production

Typical Electrical and Thermal Characteristics

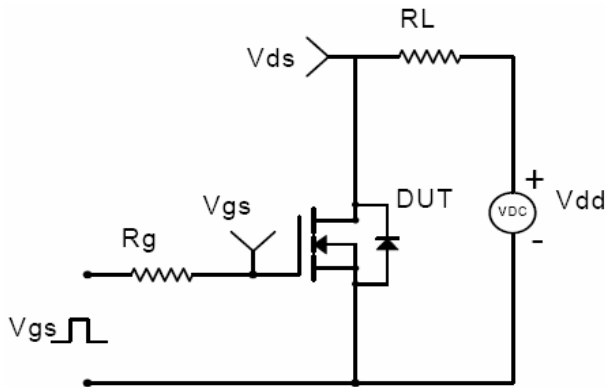


Figure 1: Switching Test Circuit

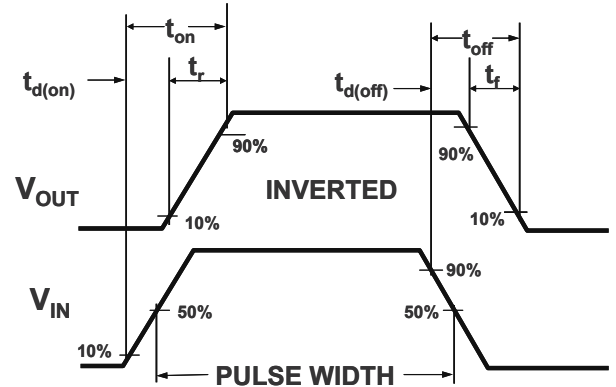


Figure 2: Switching Waveforms

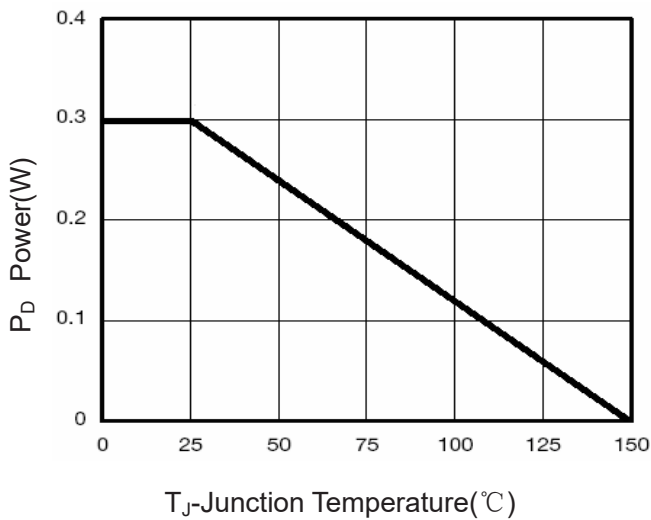


Figure 3 Power Dissipation

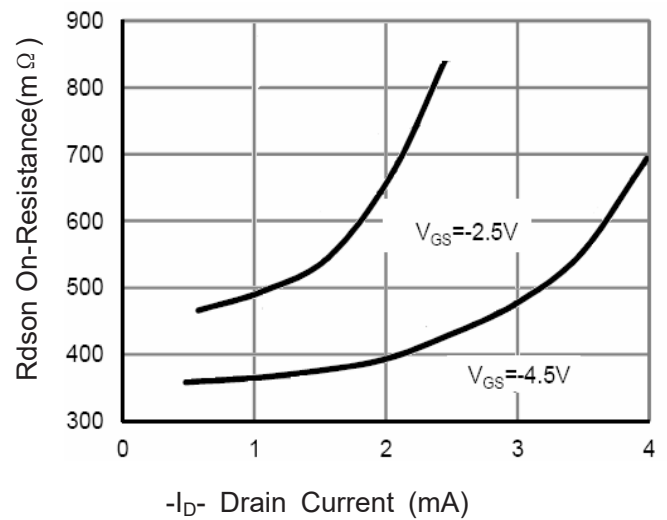


Figure 4 Drain-Source On-Resistance

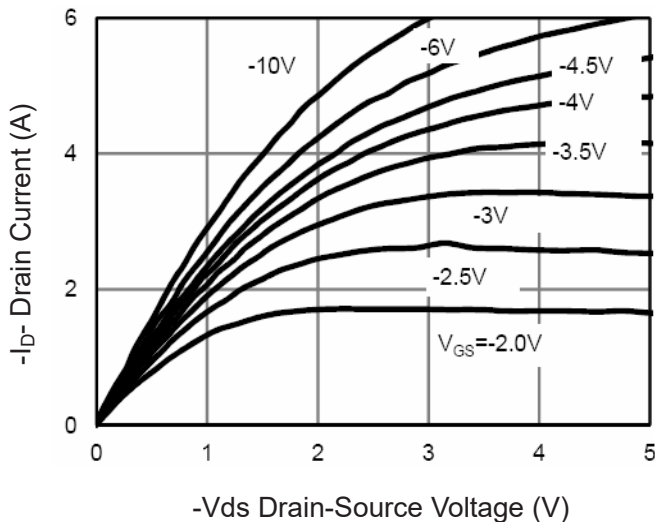


Figure 5 Output Characteristics

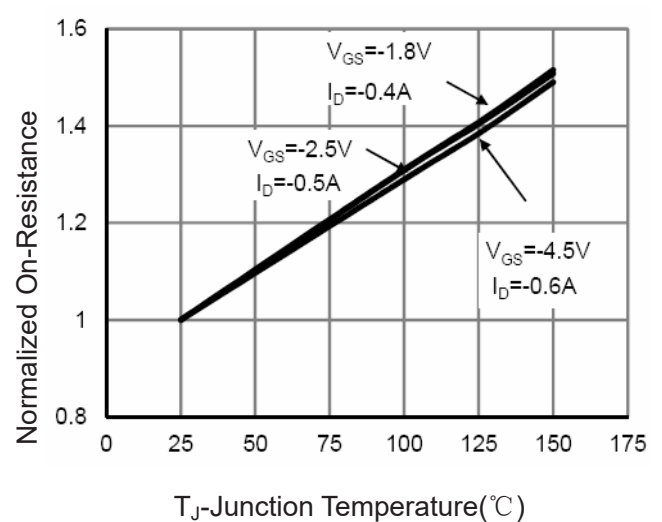
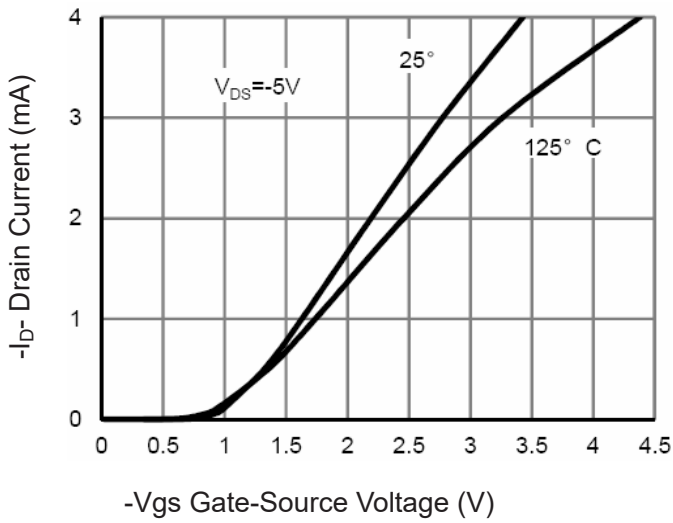
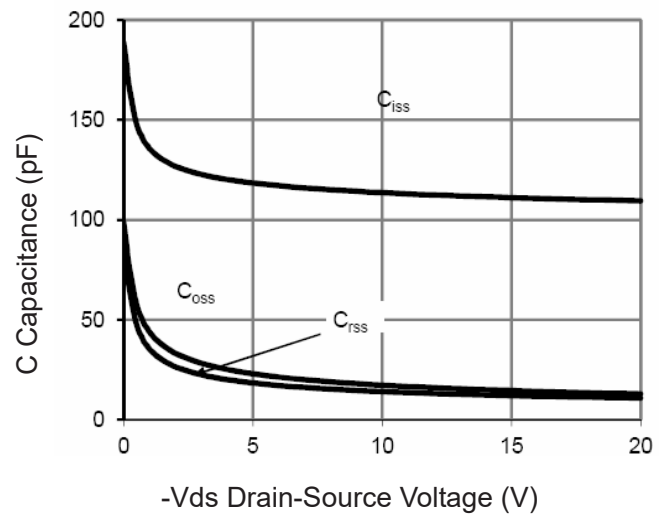
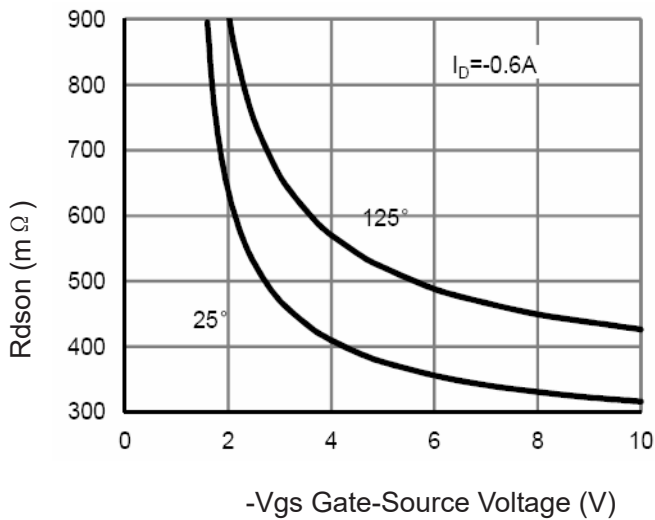
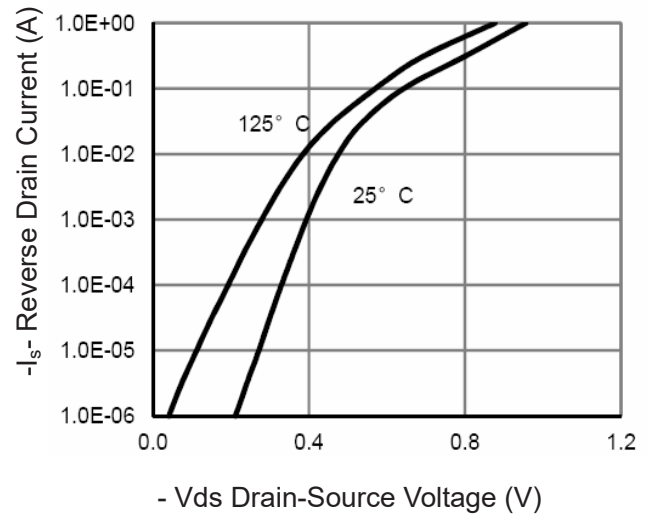
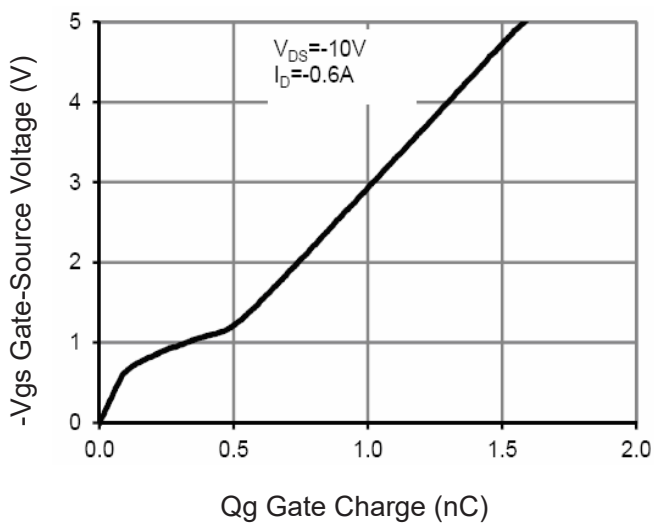
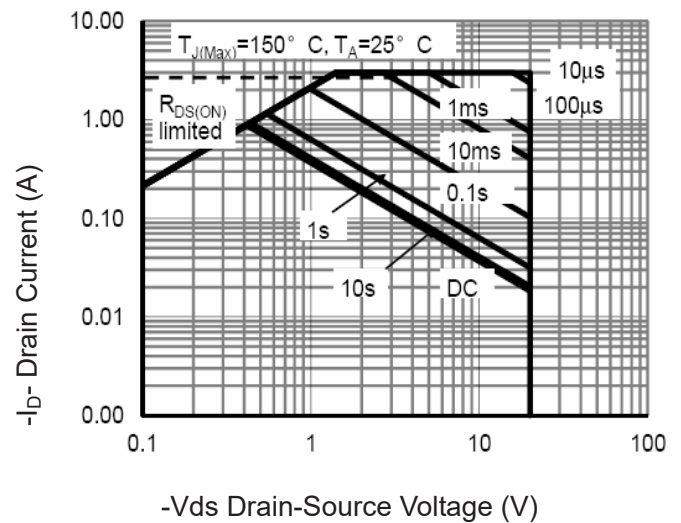


Figure 6 Drain-Source On-Resistance


Figure 7 Transfer Characteristics

Figure 8 Capacitance vs Vds

Figure 9 Rdson vs Vgs

Figure 10 Source- Drain Diode Forward

Figure 11 Gate Charge

Figure 12 Safe Operation Area

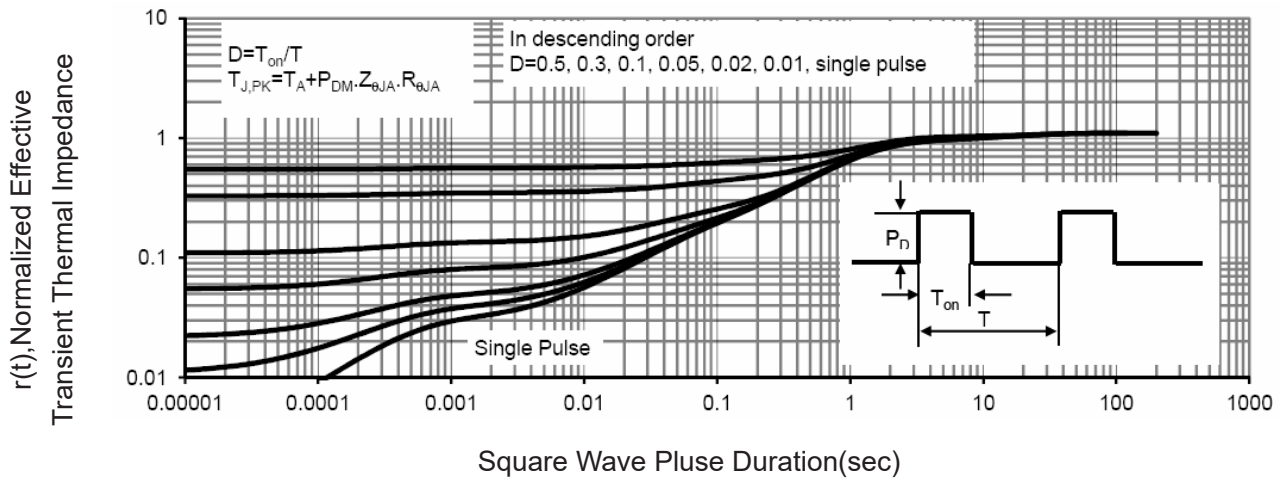


Figure 13 Normalized Maximum Transient Thermal Impedance